**Dokumentation der Qualitätskontrolle**

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| Betreiber:  | Kit:  | Hersteller:  | Prüfung nach Herstellerangabe 🞎alternative QK-Methode 🞎 |

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| Prüfmethode:  | Berechnungsformel: $$\frac{Frak. B}{Frak.A+Frak. B+Frak. C }x 100=\% Tc-X$$ | Referenzwert der radiochemischenReinheit: **≥ %** |

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| Datum | Kit Ch.-Nr. | Zeitpunkt desAnsatzes | Fraktion A | Fraktion B | Fraktion C | Radiochemische Reinheit % | Signum |
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erstellt von: \_\_\_\_\_\_\_\_\_\_\_\_ freigegeben durch: \_\_\_\_\_\_\_\_\_\_\_\_\_\_ gültig ab: \_\_\_\_\_\_\_\_\_\_\_\_\_\_ Blatt-Nr.:\_\_\_